

# **GP200MHS12**

## Half Bridge IGBT Module

Replaces GP200MHB12S January 1999 version, DS4339-5.5

DS5296-1.5 November 2000

#### **FEATURES**

- Non Punch Through Silicon
- Isolated Copper Baseplate
- Low Inductance Internal Construction

### **APPLICATIONS**

- High Power Inverters
- Motor Controllers
- Induction Heating
- Resonant Converters

The Powerline range of high power modules includes half bridge and single switch configurations covering voltages from 600V to 3300V and currents up to 4800A.

The GP200MHS12 is a half bridge 1200V, n channel enhancement mode, insulated gate bipolar transistor (IGBT) module. The IGBT has a wide reverse bias safe operating area (RBSOA) ensuring reliability in demanding applications.

The module incorporates an electrically isolated base plate and low inductance construction enabling circuit designers to optimise circuit layouts and utilise earthed heat sinks for safety.

### **ORDERING INFORMATION**

Order As:

#### **GP200MHS12**

Note: When ordering, please use the whole part number.

### **KEY PARAMETERS**

 $\begin{array}{lll} \textbf{V}_{\text{CES}} & \textbf{1200V} \\ \textbf{V}_{\text{CE(sat)}} & \textbf{(typ)} & \textbf{2.7V} \\ \textbf{I}_{\text{c}} & \textbf{(max)} & \textbf{200A} \\ \textbf{I}_{\text{C(PK)}} & \textbf{(max)} & \textbf{400A} \end{array}$ 

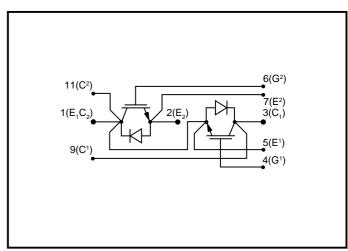


Fig. 1 Half bridge circuit diagram

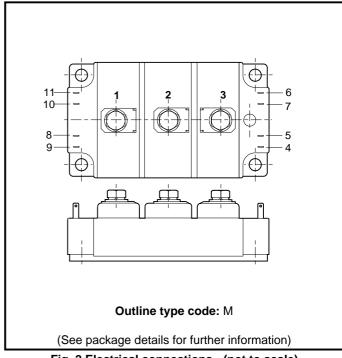


Fig. 2 Electrical connections - (not to scale)



### **ABSOLUTE MAXIMUM RATINGS - PER ARM**

Stresses above those listed under 'Absolute Maximum Ratings' may cause permanent damage to the device. In extreme conditions, as with all semiconductors, this may include potentially hazardous rupture of the package. Appropriate safety precautions should always be followed. Exposure to Absolute Maximum Ratings may affect device reliability.

T<sub>case</sub> = 25°C unless stated otherwise

Symbol	Parameter	Test Conditions	Max.	Units
V <sub>CES</sub>	Collector-emitter voltage	$V_{GE} = 0V$	1200	V
$V_{GES}$	Gate-emitter voltage	-	±20	V
I <sub>c</sub>	Collector current	DC, T <sub>case</sub> = 72°C	200	Α
I <sub>C(PK)</sub>	Peak collector current	1ms, T <sub>case</sub> = 72°C	400	Α
P <sub>max</sub>	Max. transistor power dissipation	$T_{case} = 25^{\circ}C, T_{j} = 150^{\circ}C$	1490	W
$V_{isol}$	Isolation voltage	Commoned terminals to base plate. AC RMS, 1 min, 50Hz	2500	V

### THERMAL AND MECHANICAL RATINGS

Symbol	Parameter	Test Conditions	Min.	Max.	Units
$R_{th(j-c)}$	Thermal resistance - transistor (per arm)	Continuous dissipation -	-	84	°C/kW
		junction to case			
R <sub>th(j-c)</sub>	Thermal resistance - diode (per arm)	Continuous dissipation -	-	160	°C/kW
		junction to case			
R <sub>th(c-h)</sub>	Thermal resistance - case to heatsink (per module)	Mounting torque 5Nm	-	15	°C/kW
		(with mounting grease)			
T <sub>j</sub>	Junction temperature	Transistor	-	150	°C
		Diode	-	125	°C
T <sub>stg</sub>	Storage temperature range	-	-40	125	°C
-	Screw torque	Mounting - M6	-	5	Nm
		Electrical connections - M6	-	5	Nm



### **ELECTRICAL CHARACTERISTICS**

 $T_{case}$  = 25°C unless stated otherwise.

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
I <sub>CES</sub>	Collector cut-off current	$V_{GE} = 0V$ , $V_{CE} = V_{CES}$	-	-	1	mA
		$V_{GE} = 0V$ , $V_{CE} = V_{CES}$ , $T_{case} = 125$ °C	-	-	12	mA
I <sub>GES</sub>	Gate leakage current	$V_{GE} = \pm 20V, V_{CE} = 0V$	-	-	±1	μА
V <sub>GE(TH)</sub>	Gate threshold voltage	$I_{\rm C}$ = 10mA, $V_{\rm GE}$ = $V_{\rm CE}$	4.5	-	6.5	V
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	V <sub>GE</sub> = 15V, I <sub>C</sub> = 200A	-	2.7	3.5	V
		$V_{GE} = 15V, I_{C} = 200A, T_{case} = 125^{\circ}C$	-	3.2	4.0	V
I <sub>F</sub>	Diode forward current	DC	-	-	200	А
I <sub>FM</sub>	Diode maximum forward current	t <sub>p</sub> = 1ms	-	-	400	А
V <sub>F</sub>	Diode forward voltage	I <sub>F</sub> = 200A	-	2.2	2.4	V
		I <sub>F</sub> = 200A, T <sub>case</sub> = 125°C	-	2.3	2.5	V
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 25V, V <sub>GE</sub> = 0V, f = 1MHz	-	25	-	nF
L <sub>M</sub>	Module inductance	-	-	30	-	nΗ



### **ELECTRICAL CHARACTERISTICS**

# $T_{case} = 25$ °C unless stated otherwise

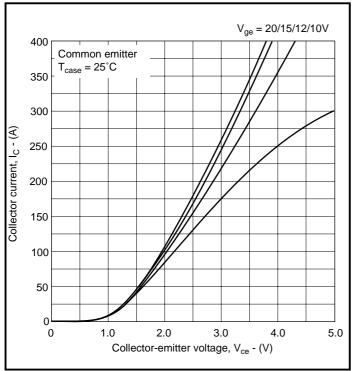
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>C</sub> = 200A	-	500	700	ns
t <sub>f</sub>	Fall time	$V_{GE} = \pm 15V$	-	150	200	ns
E <sub>OFF</sub>	Turn-off energy loss	V <sub>CE</sub> = 600V	-	25	35	mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 4.7\Omega$	-	400	550	ns
t <sub>r</sub>	Rise time	L ~ 100nH	-	80	110	ns
E <sub>on</sub>	Turn-on energy loss		-	20	30	mJ
Q <sub>rr</sub>	Diode reverse recovery charge	$I_F = 200A, V_R = 50\% V_{CES},$	-	13	20	μС
		$dI_F/dt = 2500A/\mu s$				

## $T_{case}$ = 125°C unless stated otherwise

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
t <sub>d(off)</sub>	Turn-off delay time	I <sub>c</sub> = 200A	-	600	800	ns
t <sub>f</sub>	Fall time	V <sub>GE</sub> = ±15V	-	200	250	ns
E <sub>OFF</sub>	Turn-off energy loss	V <sub>CE</sub> = 600V	-	40	50	mJ
t <sub>d(on)</sub>	Turn-on delay time	$R_{G(ON)} = R_{G(OFF)} = 4.7\Omega$	-	500	650	ns
t <sub>r</sub>	Rise time	L ~ 100nH	-	110	150	ns
E <sub>on</sub>	Turn-on energy loss		-	40	55	mJ
Q <sub>rr</sub>	Diode reverse recovery charge	$I_F = 200A, V_R = 50\% V_{CES},$	-	35	45	μС
		$dI_{F}/dt = 2000A/\mu s$				



### **TYPICAL CHARACTERISTICS**



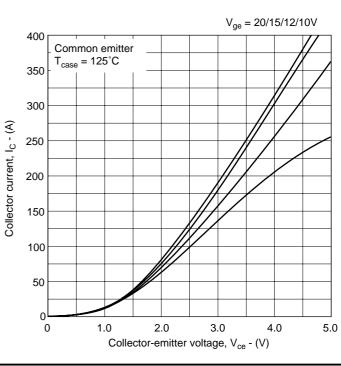


Fig. 3 Typical output characteristics

Fig. 4 Typical output characteristics

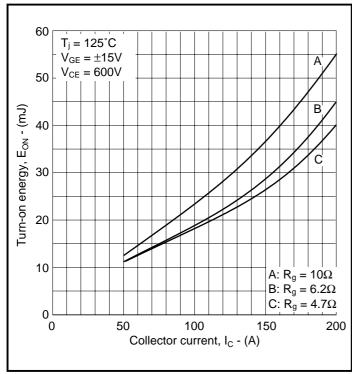


Fig. 5 Typical turn-on energy vs collector current

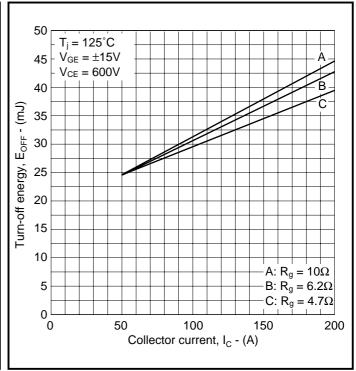
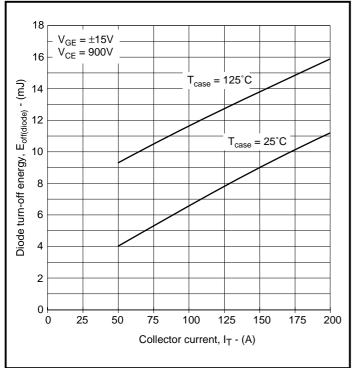


Fig. 6 Typical turn-off energy vs collector current





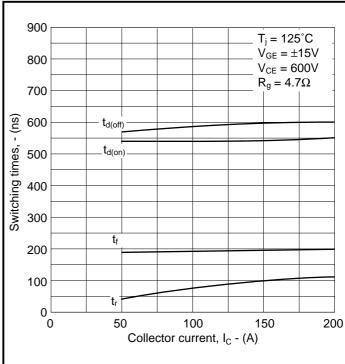


Fig. 7 Diode typical turn-off energy vs collector current

Fig. 8 Typical switching characteristics

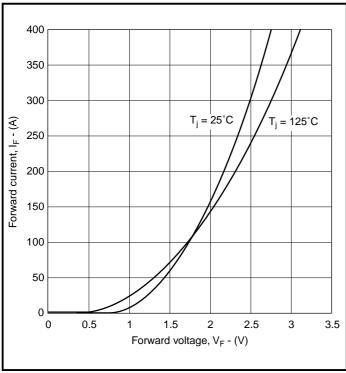


Fig. 9 Diode typical forward characteristics

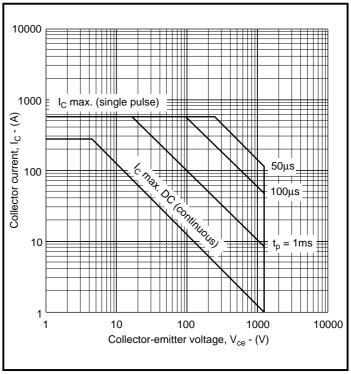
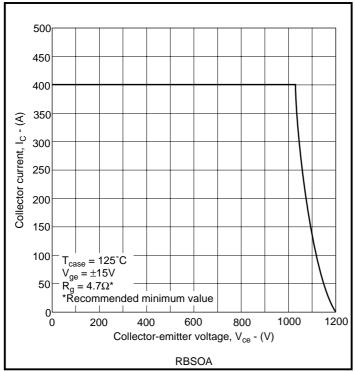


Fig. 10 Reverse bias safe operating area





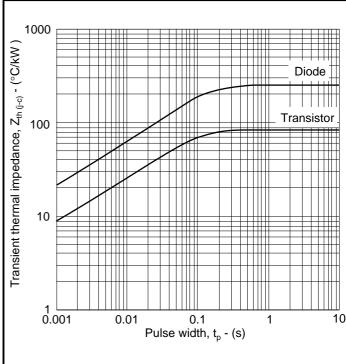
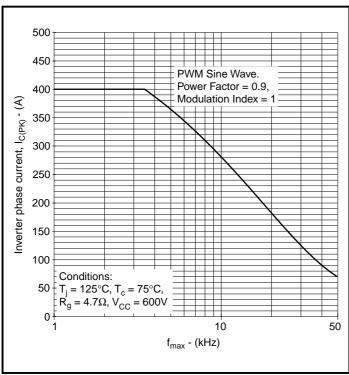


Fig. 11 Forward bias safe operating area

Fig. 12 Transient thermal impedance





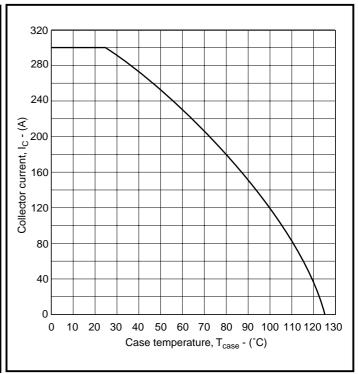
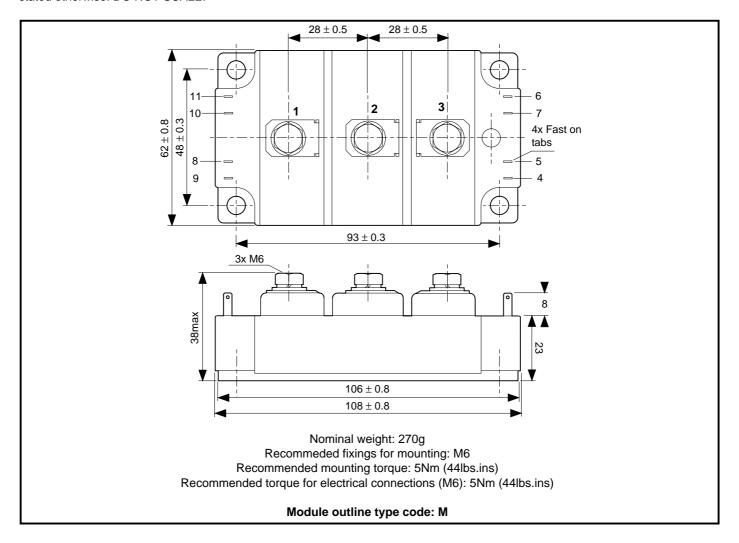


Fig. 14 DC current rating vs case temperature



### **PACKAGE DETAILS**

For further package information, please visit our website or contact your nearest Customer Service Centre. All dimensions in mm, unless stated otherwise. DO NOT SCALE.





### **ASSOCIATED PUBLICATIONS**

Title	Application Note	
	Number	
Electrostatic handling precautions	AN4502	
An introduction to IGBTs	AN4503	
IGBT ratings and characteristics	AN4504	
Heatsink requirements for IGBT modules	AN4505	
Calculating the junction temperature of power semiconductors	AN4506	
Gate drive considerations to maximise IGBT efficiency	AN4507	
Parallel operation of IGBTs – punch through vs non-punch through characteristics	AN4508	
Guidance notes for formulating technical enquiries	AN4869	
Principle of rating parallel connected IGBT modules	AN5000	
Short circuit withstand capability in IGBTs	AN5167	
Driving high power IGBTs with Concept gate drivers	AN5190	

### **POWER ASSEMBLY CAPABILITY**

The Power Assembly group provides support for those customers requiring more than the basic semiconductor switch. Using CAD design tools the group has developed a flexible range of heatsink / clamping systems in line with advances in device types and the voltage and current capability of Dynex semiconductors.

An extensive range of air and liquid cooled assemblies is available covering the range of circuit designs in general use today.

### **HEATSINKS**

The Power Assembly group has a proprietary range of extruded aluminium heatsinks. These were designed to optimise the performance of Dynex semiconductors. Data with respect to air natural, forced air and liquid cooling (with flow rates) is available on request.

For further information on device clamps, heatsinks and assemblies, please contact your nearest sales representative or customer service office.





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Preliminary Information: The product is in design and development. The datasheet represents the product as it is understood but details may change.

**Advance Information:** The product design is complete and final characterisation for volume production is well in hand.

No Annotation: The product parameters are fixed and the product is available to datasheet specification.

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